







SN54HC377, SN74HC377 SCLS307D - JANUARY 1996 - REVISED MAY 2022

SNx4HC377 Octal D-Type Flip-Flops With Clock Enable

1 Features

- Wide operating voltage range of 2 V to 6 V
- Outputs can drive up to 10 LSTTL loads
- Low power consumption, 80-µA max I_{CC}
- Typical t_{pd} = 12 ns
- ±4-mA output drive at 5 V
- Low input current of 1 µA max
- Eight flip-flops with single-rail outputs
- Clock enable latched to avoid false clocking

2 Applications

- Buffer/storage registers
- Shift registers
- Pattern generators

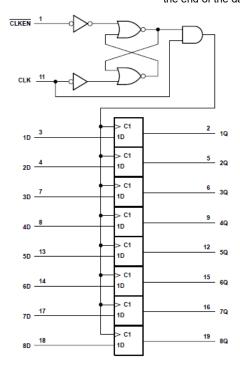
3 Description

These devices are positive-edge-triggered octal Dtype flip-flops with an enable input. The 'HC377 devices are similar to the 'HC273 devices, but feature a latched clock-enable (CLKEN) input instead of a common clear.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)
SN74HC377DW	SOIC (20)	12.80 mm × 7.50 mm
SN74HC377N	PDIP (20)	25.40 mm × 6.35 mm
SN74HC377NS	SO (20)	15.00 mm × 5.30 mm
SN54HC377J	CDIP (20)	26.92 mm × 6.92 mm
SNJ54HC377FK	LCCC (20)	8.89 mm × 8.45 mm

For all available packages, see the orderable addendum at the end of the data sheet.



Functional Block Diagram



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4 Revision History NOTE: Page numbers for previous revisions r	nay differ fr	om page numbers in the current version.	
Changes from Revision C (January 2022) to	o Revision	D (May 2022)	Page
		sed. DW was 58 is now 109.1, N was 69 is now 84.0	

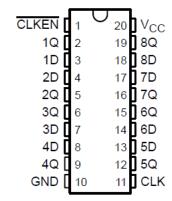
Changes from Revision B (January 2003) to Revision C (January 2022)
 Updated the numbering, formatting, tables, figures, and cross-references

Page

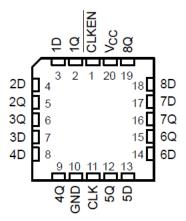
 Updated the numbering, formatting, tables, figures, and cross-references throughout the document to reflect modern data sheet standards......



5 Pin Configuration and Functions



J, DW, N, or NS package 20-Pin CDIP, SOIC, PDIP, SO Top View



FK package 20-Pin LCCC Top View



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
I _{IK}	Input clamp current ⁽²⁾	$(V_I < 0 \text{ or } V_I > V_{CC})$		±20	mA
I _{OK}	Output clamp current ⁽²⁾	$(V_O < 0 \text{ or } V_O > V_{CC})$		±20	mA
Io	Continuous output current	(V _O = 0 to V _{CC})		±25	mA
	Continuous current through V _C	cc or GND		±50	mA
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature		-65	150	°C

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 Recommended Operating Conditions⁽¹⁾

			SN	54HC377		SN	74HC377		UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNII
V _{CC}	Supply voltage		2	5	6	2	5	6	V
	High-level input voltage	V _{CC} = 2 V	1.5			1.5			
V _{IH}		V _{CC} = 4.5 V	3.15			3.15	,		V
		V _{CC} = 6 V	4.2			4.2			
		V _{CC} = 2 V			0.5			0.5	
V _{IL}	Low-level input voltage	V _{CC} = 4.5 V			1.35			1.35	V
		V _{CC} = 6 V			1.8			1.8	
VI	Input voltage		0		V _{CC}	0		V _{CC}	V
Vo	Output voltage		0		V _{CC}	0		V _{CC}	V
		V _{CC} = 2 V			1000			1000	
t _t	Input transition rise/fall time	V _{CC} = 4.5 V			500			500	ns
		V _{CC} = 6 V			400		,	400	
T _A	Operating free-air temperature		- 55		125	- 40	,	85	°C

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report Implications of Slow or Floating SMOS Inputs, literature number SCBA004.

6.3 Thermal Information

		DW (SOIC)	N (PDIP)	NS (SO)	
THERMAL I	METRIC	20 PINS	20 PINS	20 PINS	UNIT
R _{0JA}	Junction-to-ambient thermal resistance ⁽¹⁾	109.1	84.6	113.4	°C/W
R ₀ JC(top)	Junction-to-case (top) thermal resistance	76	72.5	78.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	77.6	65.3	78.4	°C/W
ΨЈΤ	Junction-to-top characterization parameter	51.5	55.3	47.1	°C/W
ΨЈВ	Junction-to-top characterization parameter	77.1	65.2	78.1	°C/W

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⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



6.3 Thermal Information (continued)

		DW (SOIC)	N (PDIP)	NS (SO)	
THERMAL MET	RIC	20 PINS	20 PINS	20 PINS	UNIT
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

6.4 Electrical Characteristics

DADAMETED	TEST CONDITIONS(1)	V 00	T	_A = 25°C		SN74HC	377	SN74HC	377	UNIT	
PARAMETER	TEST CONDITIONS(1)	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII	
		2	1.9	1.998		1.9		1.9			
	I _{OH} = -20 μA	4.5	4.4	4.499		4.4		4.4			
V _{OH}		6	5.9	5.999		5.9		5.9		V	
	I _{OH} = -4 mA	4.5	3.98	4.3		3.7		3.84			
	I _{OH} = - 5.2 mA	6	5.48	5.8		5.2		5.34			
	I _{OL} = 20 μA	2		0.002	0.1		0.1		0.1		
		4.5		0.001	0.1		0.1		0.1		
V _{OL}		6		0.001	0.1		0.1		0.1	V	
	I _{OL} = 4 mA	4.5		0.17	0.26		0.4		0.33		
	I _{OL} = 5.2 mA	6		0.15	0.26		0.4		0.33		
II	V _I = V _{CC} or 0	6		±0.1	±100		±1000		±1000	nA	
Icc	V _I = V _{CC} or 0. I _O = 0	6			8		160		80	μΑ	
Ci		2 to 6		3	10		10		10	pF	

⁽¹⁾ $V_I = V_{IH}$ or V_{IL} , unless otherwise noted.

6.5 Timing Requirements

			V	T _A = 2	5°C	SN54H	2377	SN74HC377		UNIT	
			V _{CC}	MIN	MAX	MIN	MAX	MIN	MAX	UNII	
			2		5		3		4		
f_{clock}	Clock frequency		4.5		25		16		20	MHz	
			6		29		19		23		
			2	100		150		125			
t _W	Pulse duration, CLK high or	rlow	4.5	20		30		25		ns	
			6	17		25		21			
			2	100		150		125			
		D	4.5	20		30		25		ns	
	Setup time, data before		6	17		25		21			
t _{su}	CLK↑		2	100		150		125			
		CLKEN high or low	4.5	20		30		25			
			6	17		25		21			
			2	5		5		5		ns	
t _h	Hold time, data after LE↑	CLKEN inactive or active, data	4.5	5		5		5			
		33.55	6	5		5		5			



6.6 Switching Characteristics

over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) See Parameter Measurement Information

PARAM	FROM (INPUT)	TO (OUTPUT)	V 00	T _A = 25°C			SN54H0	377	SN74HC	377	UNIT		
ETER	PROW (INPOT)	10 (001701)	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII		
			2	5	11		3		4				
f _{max}			4.5	25	54		16		20		MHz		
			6	29	64		19		23				
					2		56	160		240		200	
t _{pd}	CLK	Any	4.5		15	32		48		40	ns		
			6		12	27		41		34			
			2		38	75		110		95			
t _t		Any	4.5		8	15		22		19	ns		
		-	6		6	13		19		16			

6.7 Operating Characteristics

T_A = 25°C

		Test Conditions	TYP	UNIT
C _{pd}	Power dissipation capacitance per flip-flop	No load	30	pF

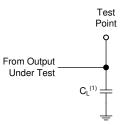
 V_{CC}

7 Parameter Measurement Information

Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_t < 2.5 ns.

For clock inputs, f_{max} is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



(1) C_L includes probe and test-fixture capacitance.

Figure 7-1. Load Circuit for Push-Pull Outputs

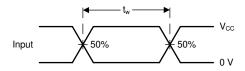


Figure 7-2. Voltage Waveforms, Standard CMOS Inputs Pulse Duration

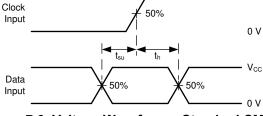


Figure 7-3. Voltage Waveforms, Standard CMOS Inputs Setup and Hold Times

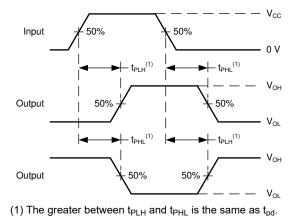
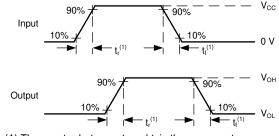


Figure 7-4. Voltage Waveforms, Propagation Delays for Standard CMOS Inputs



(1) The greater between t_{r} and t_{f} is the same as $t_{\text{t}}.$

Figure 7-5. Voltage Waveforms, Input and Output Transition Times for Standard CMOS Inputs



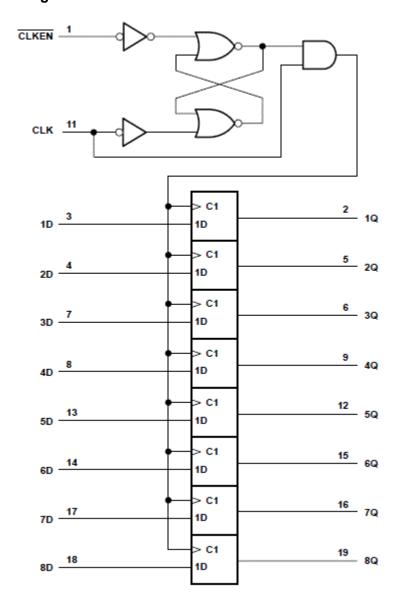
8 Detailed Description

8.1 Overview

These devices are positive-edge-triggered octal D-type flip-flops with an enable input. The 'HC377 devices are similar to the 'HC273 devices, but feature a latched clock-enable (CLKEN) input instead of a common clear.

Information at the data (D) inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock (CLK) pulse, if $\overline{\text{CLKEN}}$ is low. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When CLK is at either the high or low level, the D input has no effect at the output. These devices are designed to prevent false clocking by transitions at $\overline{\text{CLKEN}}$.

8.2 Functional Block Diagram





8.3 Device Functional Modes

Function Table (Each Flip-Flop)

	INPUTS						
CLKEN	CLK	D	Q				
Н	Х	Х	Q_0				
L	1	Н	Н				
L	1	L	L				
X	L	Х	Q_0				

9 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

10 Layout

10.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC} , whichever makes more sense for the logic function or is more convenient.

11 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

11.1 Documentation Support

11.1.1 Related Documentation

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

11.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-87807012A	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 87807012A SNJ54HC 377FK	Samples
5962-8780701RA	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8780701RA SNJ54HC377J	Samples
SN54HC377J	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SN54HC377J	Samples
SN74HC377DWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC377	Samples
SN74HC377N	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC377N	Samples
SN74HC377NE4	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC377N	Samples
SN74HC377NSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC377	Samples
SNJ54HC377FK	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 87807012A SNJ54HC 377FK	Samples
SNJ54HC377J	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8780701RA SNJ54HC377J	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

PACKAGE OPTION ADDENDUM

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(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54HC377, SN74HC377:

Catalog: SN74HC377

Military: SN54HC377

NOTE: Qualified Version Definitions:

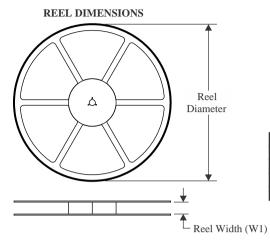
Catalog - TI's standard catalog product

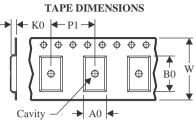
• Military - QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC377DWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74HC377DWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74HC377NSR	so	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74HC377NSR	SO	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1



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*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC377DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74HC377DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74HC377NSR	SO	NS	20	2000	367.0	367.0	45.0
SN74HC377NSR	SO	NS	20	2000	367.0	367.0	45.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-87807012A	FK	LCCC	20	1	506.98	12.06	2030	NA
SN74HC377N	N	PDIP	20	20	506	13.97	11230	4.32
SN74HC377NE4	N	PDIP	20	20	506	13.97	11230	4.32
SNJ54HC377FK	FK	LCCC	20	1	506.98	12.06	2030	NA

14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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